

ON Semiconductor®

FDMC4436BZ

P-Channel Power Trench[®] MOSFET General Description

-30 V, -18 A, 20 mΩ

Features

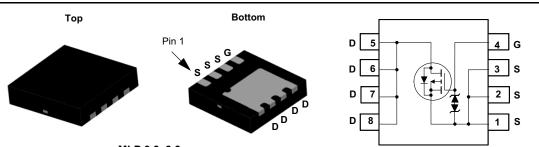
- Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = -10 V, I_D = -8.5 A
- Max $r_{DS(on)}$ = 37 m Ω at V_{GS} = -4.5 V, I_D = -6.3 A
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- HBM ESD protection level >7 kV typical (Note 4)
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

This P-Channel MOSFET is produced using ON Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- High side in DC DC Buck Converters
- Notebook battery power management

Load switch in Notebook



MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

FDMC4436BZ

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			-30	V	
V _{GS}	Gate to Source Voltage			±25	V	
	Drain Current -Continuous (Package limite	ed) T _C = 25 °C		-18		
I _D	-Continuous (Silicon limited) T _C = 25 °C		-32	•	
	-Continuous	T _A = 25 °C	(Note 1a)	-8.5	Α	
	-Pulsed			-50		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	24	mJ	
	Power Dissipation	T _C = 25 °C		31	14/	
PD	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	W	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	
	naracteristics					
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	4	°C/M			
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)			53	0,1	
Package Ma	arking and Ordering Information					
	· · · · · · · · · · · · · · · · · · ·		e Reel Size		Quantity	

MLP 3.3X3.3

13 "

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FDMC4436BZ

3000 units

12 mm

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
3V _{DSS}	Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-30			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		- 22		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = -24 V,			-1	μA
DSS	Zero Gale voltage Drain Current	V _{GS} = 0 V, T _J = 125 °C			-100	
GSS	Gate to Source Leakage Current	V_{GS} = ±25 V, V_{DS} = 0 V			±10	μA
n Chara	cteristics					
GS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \ \mu A$	-1.0	-1.9	-3.0	V
$\Delta V_{GS(th)} \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 µA, referenced to 25 °C		5.3		mV/°C
r _{DS(on)}		V _{GS} = -10 V, I _D = -8.5 A		15	20	mΩ
	Static Drain to Source On Resistance	V_{GS} = -4.5 V, I_{D} = -6.3 A		23	37	
		V _{GS} = -10 V, I _D = -8.5 A, T _J = 125 °C		21	28	
FS	Forward Transconductance	V _{DD} = -5 V, I _D = -8.5 A		24		S
ynamic	Characteristics					
'iss	Input Capacitance			1540	2045	pF
oss	Output Capacitance	─ V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz		295	395	pF
rss	Reverse Transfer Capacitance			260	385	pF
g	Gate Resistance	f = 1 MHz		5		Ω
witching	g Characteristics					
i(on)	Turn-On Delay Time			10	20	ns
	Rise Time	V _{DD} = -15 V, I _D = -8.5 A,		6	12	ns
(off)	Turn-Off Delay Time	V _{GS} = -10 V, R _{GEN} = 6 Ω		34	55	ns
	Fall Time	7		20	36	ns
۱ _g	Total Gate Charge	V _{GS} =0V to -10V		33	46	nC
g	Total Gate Charge	$V_{GS} = 0 V \text{ to } -4.5 V V_{DD} = -15 V,$		17	24	nC
۵ _{gs}	Gate to Source Charge	I _D = -8.5 A		5		nC
λ _{gd}	Gate to Drain "Miller" Charge			9		nC

Drain-Source Diode Characteristics

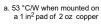
V _{SD}		V _{GS} = 0 V, I _S = -8.5A	(Note 2)	0.92	1.5	V
		V _{GS} = 0 V, I _S = -1.9 A	(Note 2)	0.75	1.2	v
t _{rr}	Reverse Recovery Time	I _F = -8.5 A, di/dt = 100 A/μs		22		ns
Q _{rr}	Reverse Recovery Charge			11		nC

NOTES:

1. R_{8JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.



3. E_{AS} of 24 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = -7 A, V_{DD} = -27 V, V_{GS} = -10 V. 100% test at L = 3 mH, I_{AS} = -4 A. 4. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

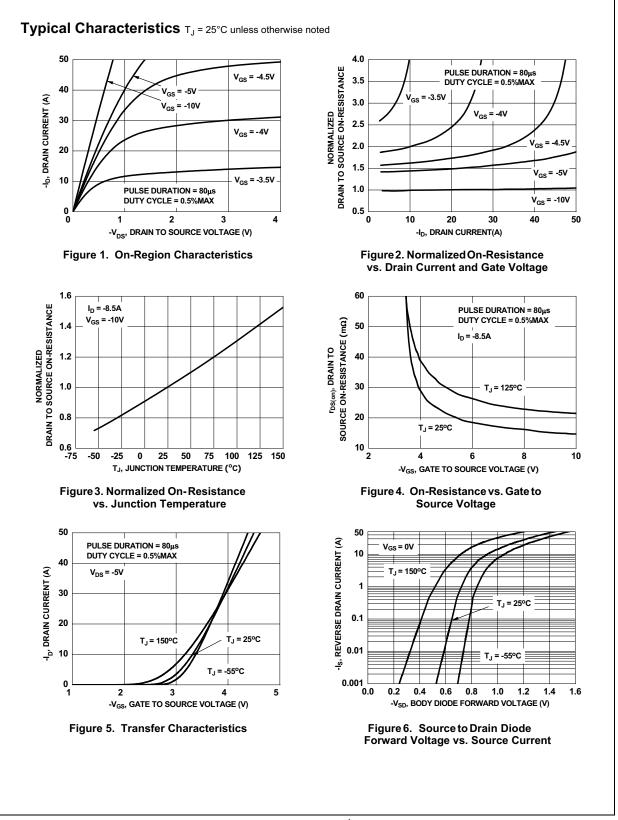


b.125 °C/W when mounted on a minimum pad of 2 oz copper



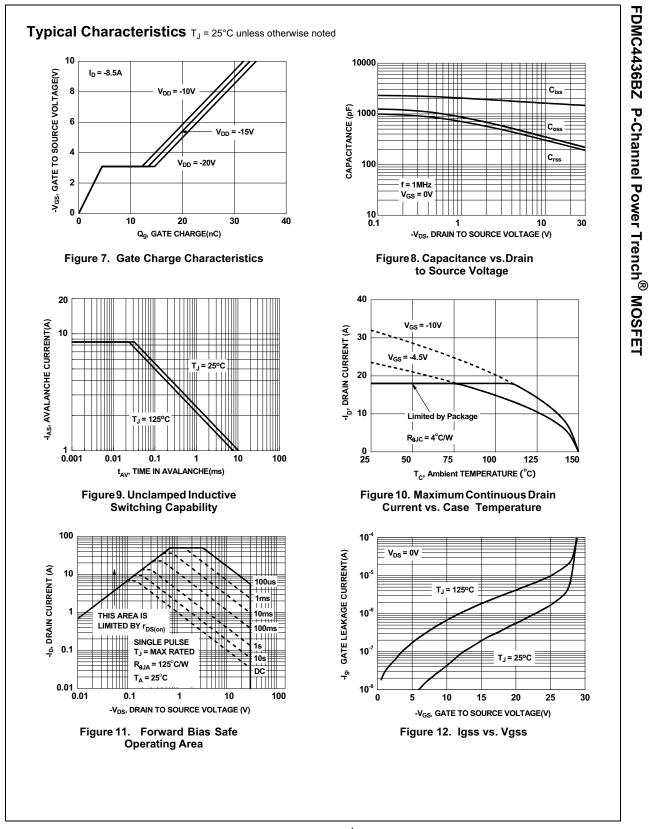
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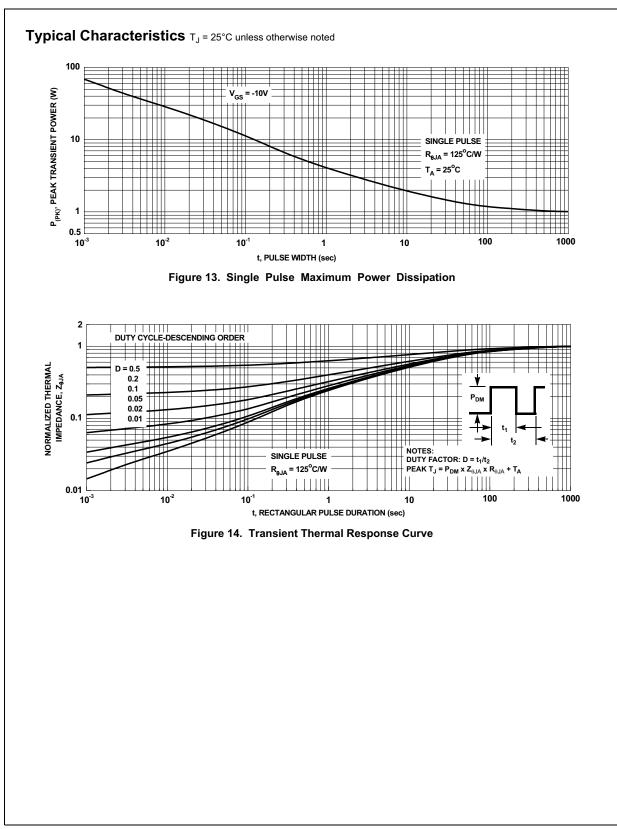


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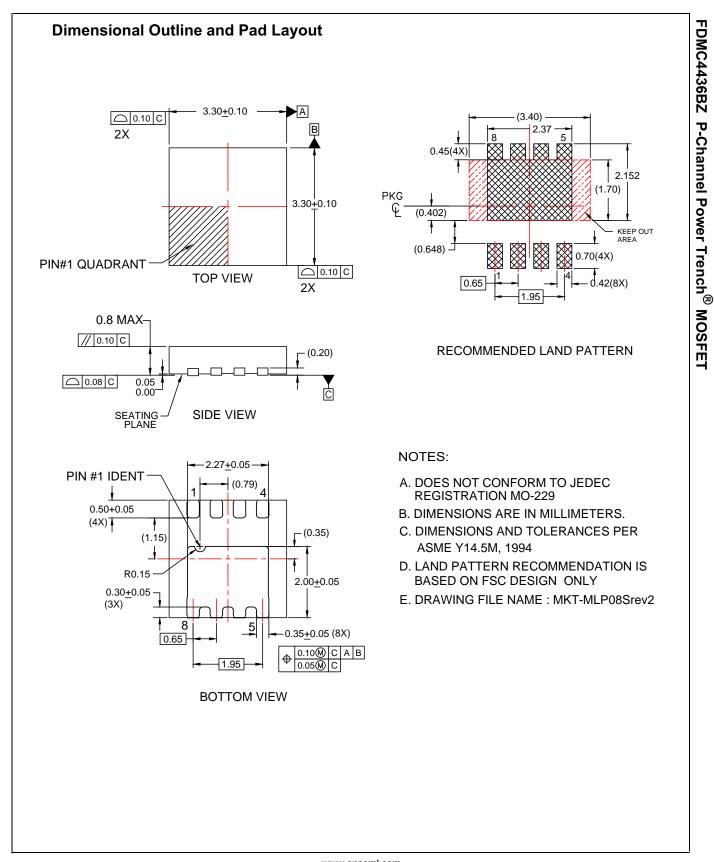


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